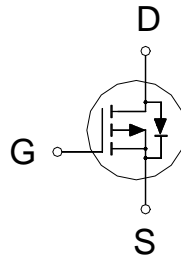


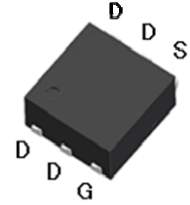
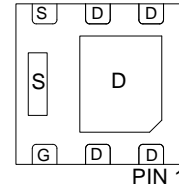
P-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

$BV_{DSS}$	-10V
$R_{DS(on)} (MAX.)$	16m $\Omega$
$I_D$	-10A



Bottom View



Pb-Free Lead Plating & Halogen Free



ABSOLUTE MAXIMUM RATINGS ( $T_A = 25\text{ }^\circ\text{C}$  Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Gate-Source Voltage		$V_{GS}$	$\pm 8$	V
Continuous Drain Current	$T_A = 25\text{ }^\circ\text{C}$	$I_D$	-10	A
	$T_A = 70\text{ }^\circ\text{C}$		-7.8	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	-40	
Power Dissipation	$T_A = 25\text{ }^\circ\text{C}$	$P_D$	2.08	W
	$T_A = 70\text{ }^\circ\text{C}$		1.33	
Operating Junction & Storage Temperature Range		$T_{j}, T_{stg}$	-55 to 150	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	$R_{\theta JC}$		12	$^\circ\text{C} / \text{W}$
Junction-to-Ambient <sup>3</sup>	$R_{\theta JA}$		60	

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle  $\leq 1\%$

<sup>3</sup>60 $^\circ\text{C} / \text{W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



ELECTRICAL CHARACTERISTICS ( $T_J = 25\text{ }^\circ\text{C}$ , Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-10			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.35	-0.75	-1.20	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 8V$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -8V, V_{GS} = 0V$			-1	$\mu A$
		$V_{DS} = -8V, V_{GS} = 0V, T_J = 125\text{ }^\circ\text{C}$			-10	
On-State Drain Current <sup>1</sup>	$I_{D(ON)}$	$V_{DS} = -5V, V_{GS} = -4.5V$	10			A
Drain-Source On-State Resistance <sup>1</sup>	$R_{DS(ON)}$	$V_{GS} = -4.5V, I_D = -6A$		12	16	$m\Omega$
		$V_{GS} = -2.5V, I_D = -5A$		18	24	
		$V_{GS} = -1.8V, I_D = -3A$		22	32	
Forward Transconductance <sup>1</sup>	$g_{fs}$	$V_{DS} = -5V, I_D = -6A$		16		S
<b>DYNAMIC</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = -5V, f = 1MHz$		1723		$pF$
Output Capacitance	$C_{oss}$			561		
Reverse Transfer Capacitance	$C_{rss}$			431		
Total Gate Charge <sup>1,2</sup>	$Q_g$	$V_{DS} = -6V, V_{GS} = -4.5V,$ $I_D = -6A$		13.9		$nC$
Gate-Source Charge <sup>1,2</sup>	$Q_{gs}$			2.5		
Gate-Drain Charge <sup>1,2</sup>	$Q_{gd}$			4.8		
Turn-On Delay Time <sup>1,2</sup>	$t_{d(on)}$	$V_{DS} = -5V,$ $I_D = -1A, V_{GS} = -4.5V, R_{GS} = 6\Omega$		15		$nS$
Rise Time <sup>1,2</sup>	$t_r$			25		
Turn-Off Delay Time <sup>1,2</sup>	$t_{d(off)}$			40		
Fall Time <sup>1,2</sup>	$t_f$			30		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (<math>T_C = 25\text{ }^\circ\text{C}</math>)</b>						
Continuous Current	$I_S$				-3	A
Pulsed Current <sup>3</sup>	$I_{SM}$				-12	
Forward Voltage <sup>1</sup>	$V_{SD}$	$I_F = I_S, V_{GS} = 0V$			-1.2	V

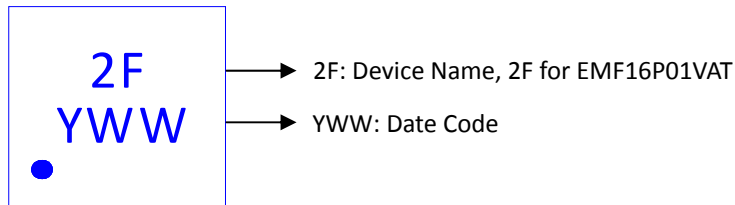
<sup>1</sup>Pulse test : Pulse Width  $\leq 300\ \mu\text{sec}$ , Duty Cycle  $\leq 2\%$ .

<sup>2</sup>Independent of operating temperature.

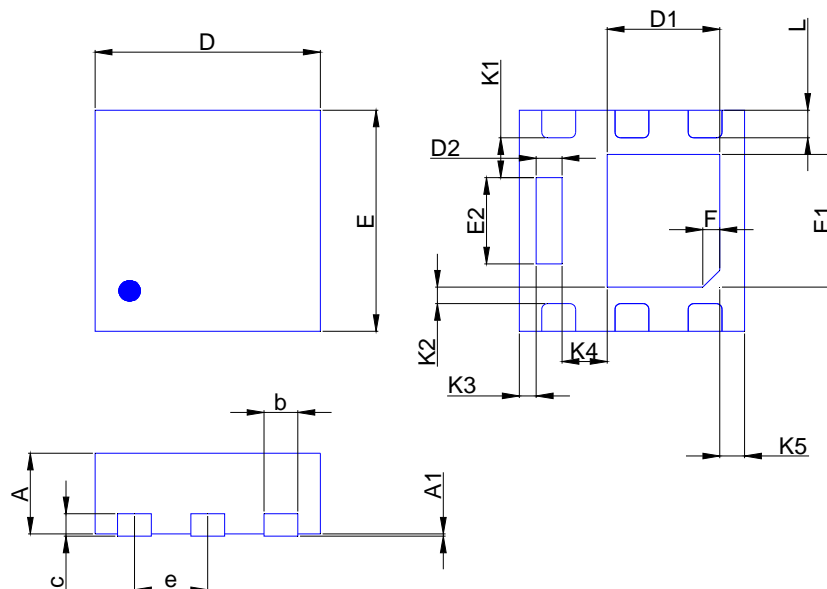
<sup>3</sup>Pulse width limited by maximum junction temperature.

Ordering & Marking Information:

Device Name: EMF16P01VAT for EDFN 2 x 2



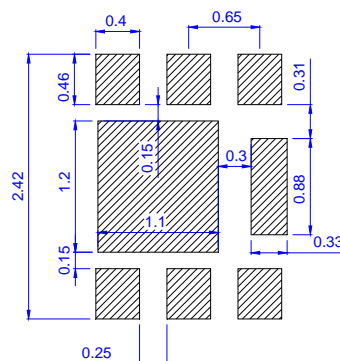
Outline Drawing



Dimension in mm

Dimension	A	A1	b	c	D	D1	D2	E	E1	E2	e	F	f	K1	K2	L	K3	K4	K5
Min.	0.50	0.00	0.25		1.9	1.0	0.13	1.9	1.1	0.65				0.306	0.10	0.2	0.10	0.27	0.17
Typ.		0.02	0.30	0.1	2.0	1.1	0.25	2.0	1.2	0.75	0.65	0.15	45°	0.356	0.15	0.25	0.15		0.22
Max.	0.65	0.05	0.35		2.1	1.2	0.35	2.1	1.3	0.88				0.406	0.20	0.3	0.20		0.27

Recommended minimum pads



TYPICAL CHARACTERISTICS

